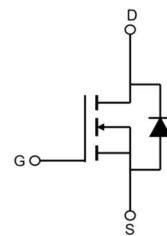


Feature

- 650V,2A
- $R_{DS\ (ON)} < 5.0\ \Omega$ @ $V_{GS}=10V$ TYP:4.0 Ω
- Fast Switching
- Lead free product is acquired
- Excellent $R_{DS\ (ON)}$ and Low Gate Charge



Schematic Diagram



Marking and pin assignment

Application

- PWM applications
- Load Switch
- Power management

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity (PCS)
2N65U	AP2N65U	TO-251	-	-	-

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	650	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current ($T_a = 25^\circ C$)	I_D	2	A
Continuous Drain Current ($T_a = 100^\circ C$)	I_D	1.25	A
Pulsed Drain Current ⁽¹⁾	I_{DM}	8	A
Single Pulsed Avalanche Energy ⁽²⁾	E_{AS}	120	mJ
Power Dissipation	P_D	40	W
Thermal Resistance from Junction to Case	R_{eJC}	2.84	$^\circ C/W$
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55~+150	$^\circ C$

MOSFET ELECTRICAL CHARACTERISTICS($T_a=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Type	Max	Unit
Static Characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	650	-	-	V
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 650V, V_{GS} = 0V$	-	-	1	μA
Gate-body leakage current	I_{GSS}	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	± 100	nA
Gate threshold voltage ⁽³⁾	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	2	3.3	4	V
Drain-source on-resistance ⁽³⁾	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 2A$	-	4.0	5.0	Ω
Forward transconductance ⁽³⁾	g_{FS}	$V_{DS} = 40V, I_D = 1.0A$	-	1.5	-	S
Dynamic characteristics						
Input Capacitance	C_{iss}	$V_{DS} = 25V, V_{GS} = 0V, f = 1MHz$	-	290	-	pF
Output Capacitance	C_{oss}		-	31	-	
Reverse Transfer Capacitance	C_{rss}		-	9	-	
Switching characteristics						
Turn-off delay time	$t_{d(off)}$	$V_{DD}=325V, I_D=2A, V_{GS}=10V, R_G=25\Omega$	-	24	-	ns
Total Gate Charge	Q_g	$V_{DS}=520V, ID=2A, VGS=10V$	-	6.7	-	nC
Gate-Source Charge	Q_{gs}		-	1.9	-	
Gate-Drain Charge	Q_{gd}		-	1.8	-	
Source-Drain Diode characteristics						
Diode Forward voltage ⁽³⁾	V_{DS}	$V_{GS} = 0V, I_S = 2A$	-	-	1.4	V
Diode Forward current ⁽⁴⁾	I_S		-	-	2	A
Body Diode Reverse Recovery Time	t_{rr}	$T_J=25^\circ C, IF=2A, di/dt=100A/us$		368		ns
Body Diode Reverse Recovery Charge	Q_{rr}	$T_J=25^\circ C, IF=2A, di/dt=100A/us$		1.0		uc

Notes:

1. Repetitive Rating: pulse width limited by maximum junction temperature
2. EAS Condition: $T_J=25^\circ C, V_{DD}=50V, R_G=2.0\Omega, L=56mH$
3. Pulse Test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
4. Surface Mounted on FR4 Board, $t \leq 10$ sec

Typical Performance Characteristics

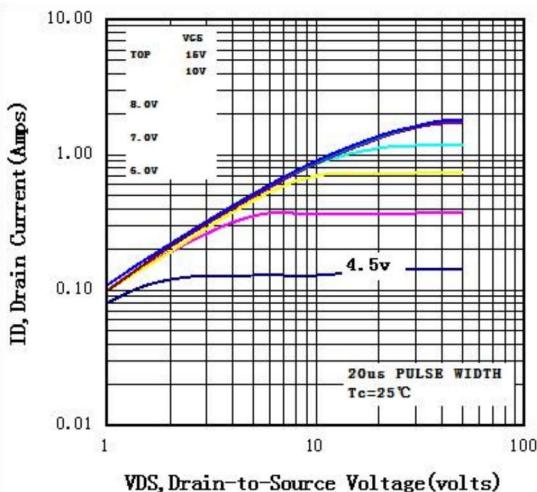


Fig1 Typical Output Characteristics, $T_c=25^\circ\text{C}$

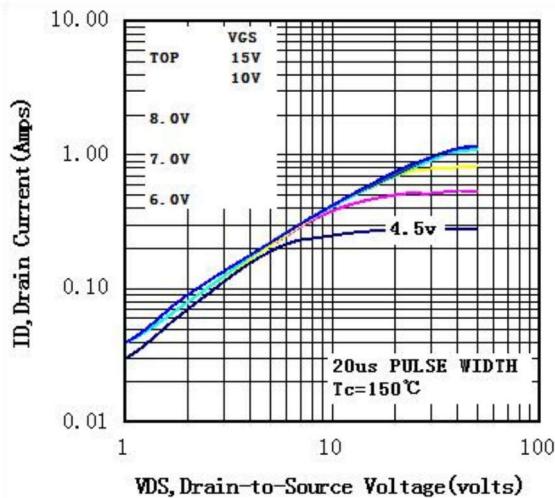


Fig2 Typical Output Characteristics, $T_c=150^\circ\text{C}$

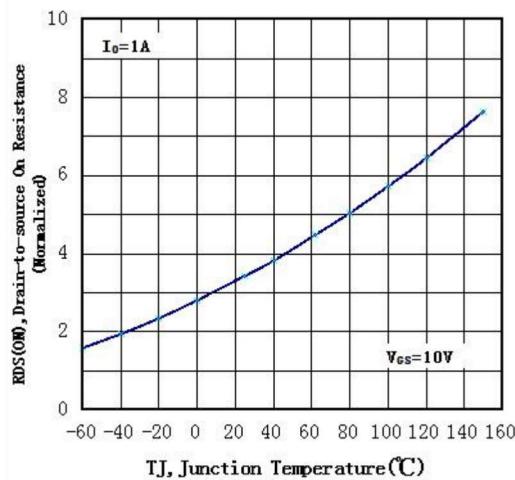


Fig3 Normalized On-Resistance Vs. Temperature

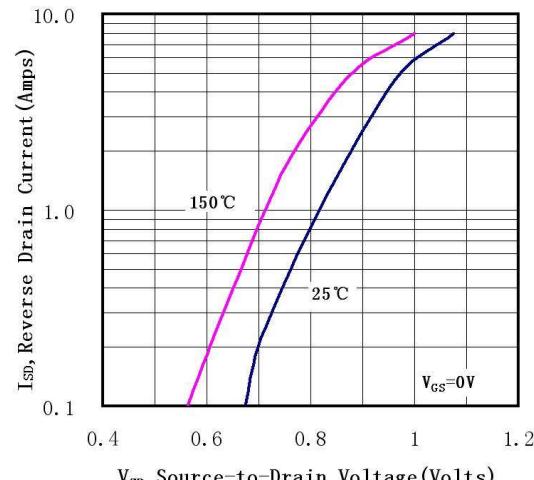


Fig4 Typical Source-Drain Diode Forward Voltage

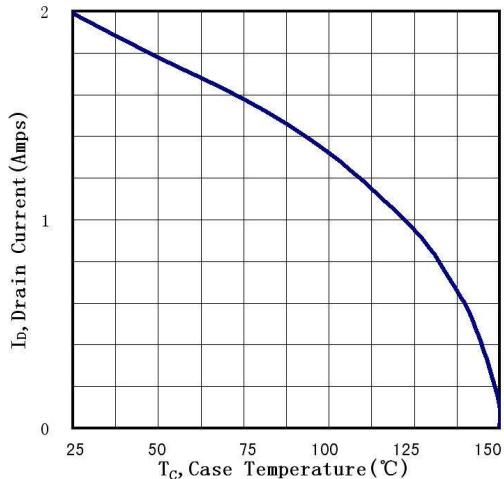


Fig5 Maximum Drain Current Vs. Case Temperature

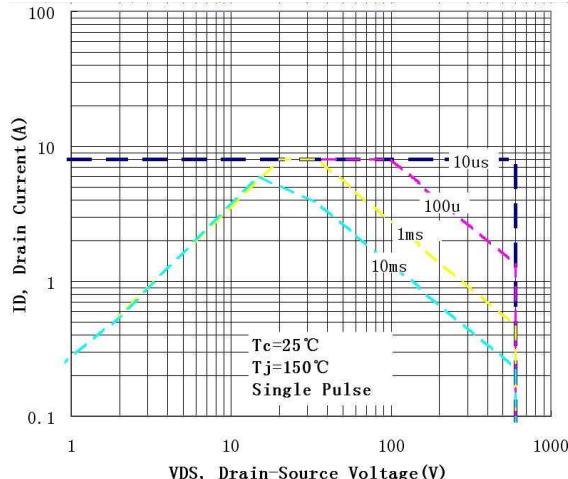


Fig6 Maximum Safe Operating Area

TO-251 Package Information

